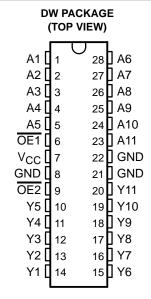
SN74BCT2410 11-BIT MOS MEMORY DRIVER WITH 3-STATE OUTPUTS

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- State-of-the-Art BiCMOS Design Significantly Reduces I_{CCZ}
- ESD Protection Exceeds 2000 V Per MIL-STD-883C, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Output Ports Have Equivalent 33- Ω Series Resistors, So No External Resistors Are Required
- Packaged in Plastic Small-Outline (DW) Package

description

The SN74BCT2410 is a noninverting 11-bit buffer/line driver specifically designed to drive MOS DRAMs of up to 4 megabits. It is also suitable for use with wide data paths or buses carrying parity. The outputs, which are designed to source 1 mA and sink 12 mA, include $33-\Omega$ series resistors to reduce overshoot and undershoot.



The output-enable $(\overline{OE1} \text{ and } \overline{OE2})$ inputs are routed internally to a two-input AND gate with active-low inputs. When both $\overline{OE1}$ and $\overline{OE2}$ are low, the Y outputs are active (high or low logic level). When either $\overline{OE1}$ or $\overline{OE2}$ is high, the Y outputs are in the high-impedance state.

The multiple ground pins of the SN74BCT2410 reduce switching noise for more reliable system operation.

The SN74BCT2410 is characterized for operation from 0°C to 70°C.

FUNCTION TABLE

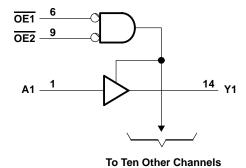
INPUTS			ОИТРИТ
OE1	OE2	Α	Y
L	L	L	L
L	L	Н	н
X	Н	Χ	Z
Н	X	Χ	Z

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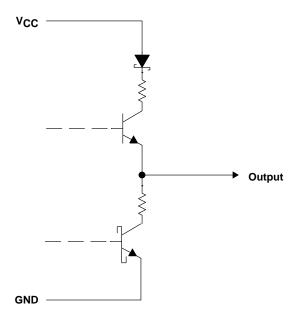
logic symbol†

OE1	6 0	&	EN		
A 4	1	<u> </u>	 > ▽	l 14	V4
A1 A2	2		> \(\nabla \)	13	Y1 Y2
	3			12	Y3
A3 A4	4			11	· 13
A4 A5	5			10	Y5
A6	28			15	· 15
A6 A7	27			16	
	26			17	Y7
A8 A9	25			18	Y8 Y9
A10	24			19	Y10
A10	23			20	Y11
AII					

logic diagram (positive logic)



schematic of each output



 $[\]ensuremath{^{\dagger}}$ This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	0.5 V to 7 V
Input voltage range, V _I (see Note 1)	0.5 V to 7 V
Voltage range applied to any output in the disabled or power-off state, VO	0.5 V to 5.5 V
Voltage range applied to any output in the high state, VO	-0.5 V to V_{CC}
Input clamp current, I_{IK} ($V_I < 0$)	–30 mÅ
Current into any output in the low state, I _O	60 mA
Operating free-air temperature range	
Storage temperature range	65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability

recommended operating conditions (see Note 2)

		MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
V _{IL}	Low-level input voltage			0.8	V
liK	Input clamp current			-18	mA
IOH	High-level output current			-12	mA
lOL	Low-level output current			12	mA
TA	Operating free-air temperature	0		70	°C

NOTE 2: Unused or floating inputs must be held high or low.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		TYP‡	MAX	UNIT
VIK	$V_{CC} = 4.5 \text{ V},$	I _I = -18 mA			-1.2	V
Vou	V _{CC} = 4.5 V	$I_{OH} = -3 \text{ mA}$	2.5	3.5		٧
VOH	VCC = 4.5 V	$I_{OH} = -12 \text{ mA}$	2	2 3.1		v
VOL	$V_{CC} = 4.5 \text{ V},$	I _{OL} = 12 mA		0.42	0.8	V
lį	$V_{CC} = 5.5 \text{ V},$	V _I = 5.5 V			0.1	mA
lН	$V_{CC} = 5.5 \text{ V},$	V _I = 2.7 V			20	μΑ
Ι _Ι L	$V_{CC} = 5.5 \text{ V},$	V _I = 0.5 V			-0.1	mA
lozh	$V_{CC} = 5.5 \text{ V},$	$V_0 = 2.7 \text{ V}$			50	μΑ
lozL	$V_{CC} = 5.5 V,$	V _O = 0.5 V			-50	μΑ
ΙΟ§	$V_{CC} = 5.5 \text{ V},$	V _O = 2.25 V	-15		-70	mA
ICCL	$V_{CC} = 5.5 \text{ V},$	V _O = 0			40	mA
Іссн	$V_{CC} = 5.5 \text{ V},$	V _O = 0			40	mA
Iccz	$V_{CC} = 5.5 \text{ V},$	V _O = 0			6.5	mA
C _i	V _{CC} = 5 V,	$V_{I} = 2.5 \text{ V or } 0.5 \text{ V}$		6		pF
Co	$V_{CC} = 5 V$,	$V_0 = 2.5 \text{ V or } 0.5 \text{ V}$		10	·	pF

[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



NOTE 1: The input negative-voltage rating may be exceeded if the input clamp-current rating is observed.

[§] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

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switching characteristics over recommended ranges of supply voltage and operating free-air temperature, C_L = 50 pF (unless otherwise noted) (see Note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 5 V, T _A = 25°C			MIN	MAX	UNIT
	(1141 01)	(0011 01)	MIN	TYP	MAX			
t _{PLH}	А	V	2	4.9	6.5	2	8.5	20
t _{PHL}		1	2.3	5.6	7.5	2.3	8.5	ns
^t PZH	ŌĒ	V	4.5	10.3	13	4.5	16.5	20
t _{PZL}		1	2	11.4	16	2	19	ns
^t PHZ	ŌĒ	V	3.4	7	9.5	3.4	12	
t _{PLZ}		ſ	5.3	9.2	11.5	5.3	13.5	ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.



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